


<b>Issue Classification</b> 		<b>Application/Control No.</b> 10069831	<b>Applicant(s)/Patent under Reexamination</b> SATO ET AL.
<b>Examiner</b> Shin, Kyung H		<b>Art Unit</b> 2143	

ORIGINAL		INTERNATIONAL CLASSIFICATION				NON-CLAIMED				
CLASS	SUBCLASS	CLAIMED								
709	203	G	0	6	F	15 / 16				
CROSS REFERENCE(S)										
SUBCLASS (ONE SUBCLASS PER BLOCK)										
709	227						200			
705	5									
Kyung Hye Shin 7/21/2006 (Assistant Examiner) (Date)		DANIEL W. LEE SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Date)								
(Legal Instruments Examiner) 07/25/06 (Date)										
(Primary Examiner)		Total Claims Allowed: 19								
		O.G. Print Claim(s) 1								
		O.G. Print Fig. 6								